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Product data sheet

# 1. General description

N-channel enhancement mode vertical Double-Diffused Field-Effect Transistor (D-MOSFET) in a SOT89 (SC-62) medium power and flat lead Surface-Mounted Device (SMD) plastic package.

### 2. Features and benefits

- Direct interface to Complementary (C-MOS) transistor and Transistor-Transistor Logic (TTL) devices.
- Very fast switching
- No secondary breakdown

# 3. Applications

- Relay driver
- High-speed line driver
- Load-side loadswitch
- Switching circuits

### 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C		-	-	200	V
V <sub>GS</sub>	gate-source voltage			-20	-	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 25 °C	[1]	-	-	0.4	Α
Static characte	Static characteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 0.4 \text{ A}; T_j = 25 \text{ °C}$		-	1.6	3	Ω

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.





### 200 V, N-channel vertical D-MOS transistor

# 5. Pinning information

### Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		D ±
2	D	drain		
3	G	gate	3 2 1	G (S)
			SOT89	017aaa253

# 6. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BSS87	SOT89	plastic surface-mounted package; die pad for good heat transfer; 3 leads	SOT89			

# 7. Marking

Table 4. Marking codes

Type number	Marking code
BSS87	KA

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200 V, N-channel vertical D-MOS transistor

# **Limiting values**

Table 5. **Limiting values** 

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> = 25 °C		-	200	V
$V_{GS}$	gate-source voltage			-20	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 25 °C; t ≤ 5 s	[1]	-	0.7	Α
		V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 25 °C	[1]	-	0.4	Α
		V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 100 °C	[1]	-	0.2	Α
I <sub>DM</sub>	peak drain current	$T_{amb}$ = 25 °C; single pulse; $t_p \le 10 \mu s$		-	1.6	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C	[2]	-	0.58	W
			[1]	-	1	W
		T <sub>sp</sub> = 25 °C		-	12.5	W
Tj	junction temperature			-55	150	°C
T <sub>amb</sub>	ambient temperature			-55	150	°C
T <sub>stg</sub>	storage temperature			-65	150	°C
Source-drain	diode		-		'	,
I <sub>S</sub>	source current	T <sub>amb</sub> = 25 °C	[1]	-	0.4	Α

Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>. Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

### 200 V, N-channel vertical D-MOS transistor

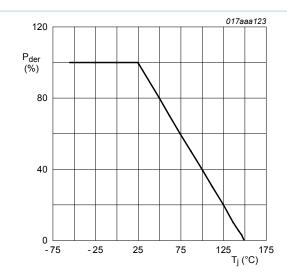


Fig. 1. MOSFET transistor: Normalized total power dissipation as a function of junction temperature

$$P_{\textit{der}} = \frac{P_{\textit{tot}}}{P_{\textit{tot}(25^{\circ}\textit{C})}} \times 100 \%$$

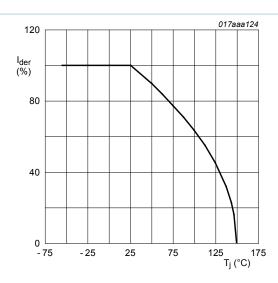
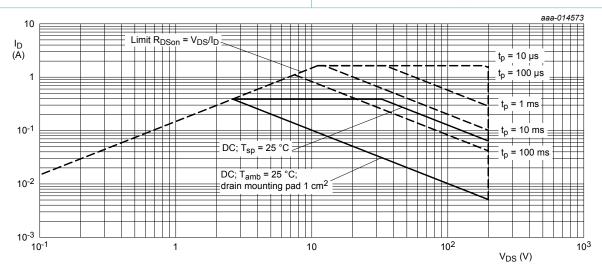


Fig. 2. MOSFET transistor: Normalized continuous drain current as a function of junction temperature

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$



I<sub>DM</sub> = single pulse

Fig. 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drainsource voltage

200 V, N-channel vertical D-MOS transistor

### Thermal characteristics

**Thermal characteristics** Table 6.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
fre	thermal resistance		[1]	-	190	216	K/W
	from junction to ambient		[2]	-	105	125	K/W
	ambient	in free air; t ≤ 5 s	<u>[2]</u>	-	36	42	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point			-	6	10	K/W

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.

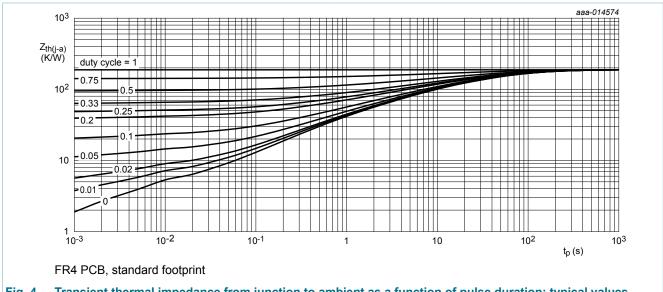
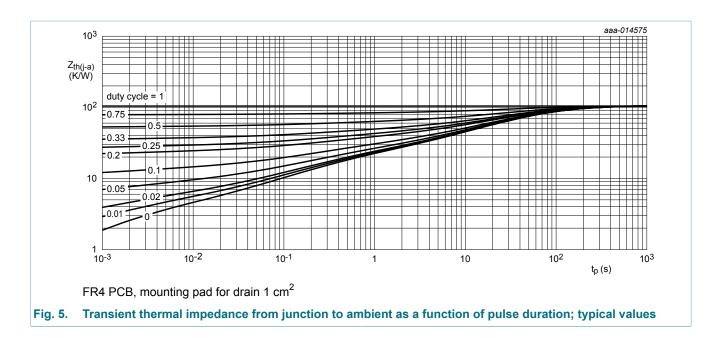


Fig. 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

### 200 V, N-channel vertical D-MOS transistor



### 200 V, N-channel vertical D-MOS transistor

## 10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$I_D$ = 250 $\mu$ A; $V_{GS}$ = 0 V; $T_j$ = 25 °C	200	-	-	V
$V_{GSth}$	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	0.8	-	2.8	V
I <sub>DSS</sub>	drain leakage current	V <sub>DS</sub> = 60 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	200	nA
		V <sub>DS</sub> = 200 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	60	μA
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	100	nA
		$V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	-	-100	nA
R <sub>DSon</sub>	drain-source on-state	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 0.4 A; T <sub>j</sub> = 25 °C	-	1.6	3	Ω
resista	resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 0.4 A; T <sub>j</sub> = 150 °C	-	3.7	7	Ω
		$V_{GS}$ = 4.5 V; $I_D$ = 0.3 A; $T_j$ = 25 °C	-	1.9	4	Ω
9 <sub>fs</sub>	forward transconductance	$V_{DS} = 25 \text{ V}; I_D = 0.4 \text{ A}; T_j = 25 \text{ °C}$	-	0.8	-	S
Dynamic ch	naracteristics		<u> </u>			
Q <sub>G(tot)</sub>	total gate charge	$V_{DS}$ = 50 V; $I_{D}$ = 0.25 A; $V_{GS}$ = 10 V;	-	5.5	10	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C	-	0.3	-	nC
$Q_{GD}$	gate-drain charge		-	1.4	-	nC
C <sub>iss</sub>	input capacitance	$V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}; V_{GS} = 0 \text{ V};$	-	100	120	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C	-	20	30	pF
C <sub>rss</sub>	reverse transfer capacitance		-	10	15	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 50 V; $I_{D}$ = 0.25 A; $V_{GS}$ = 10 V;	-	2.7	6	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	3.7	6	ns
t <sub>d(off)</sub>	turn-off delay time		-	16.4	30	ns
t <sub>f</sub>	fall time		-	7.5	20	ns
Source-drai	in diode		l .		1	
$V_{SD}$	source-drain voltage	I <sub>S</sub> = 0.4 A; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 25 °C	-	0.8	1.2	V

### 200 V, N-channel vertical D-MOS transistor

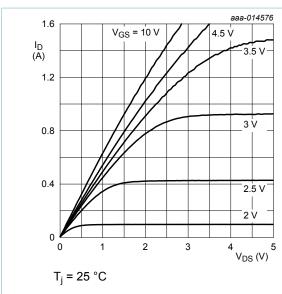


Fig. 6. Output characteristics: drain current as a function of drain-source voltage; typical values

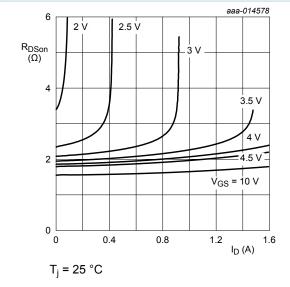


Fig. 8. Drain-source on-state resistance as a function of drain current; typical values

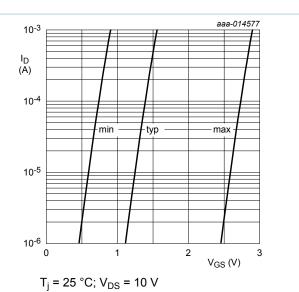


Fig. 7. Sub-threshold drain current as a function of gate-source voltage

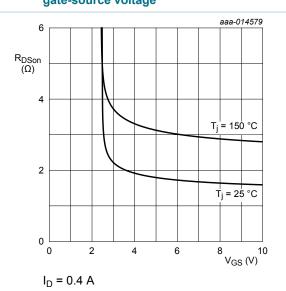


Fig. 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

### 200 V, N-channel vertical D-MOS transistor

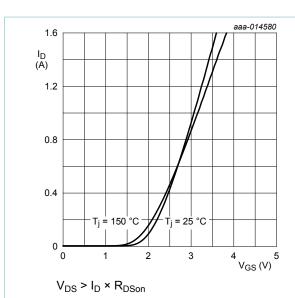


Fig. 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

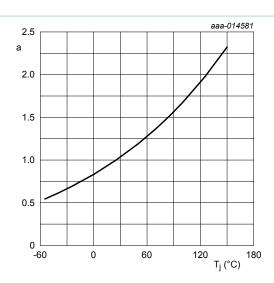


Fig. 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values

$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

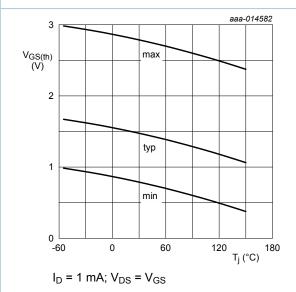


Fig. 12. Gate-source threshold voltage as a function of junction temperature

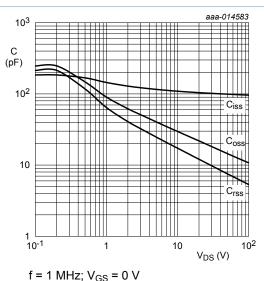


Fig. 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

### 200 V, N-channel vertical D-MOS transistor

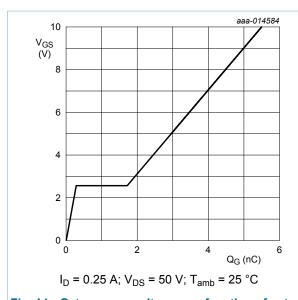


Fig. 14. Gate-source voltage as a function of gate charge; typical values

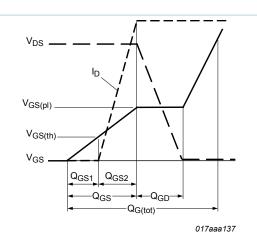


Fig. 15. MOSFET transistor: Gate charge waveform definitions

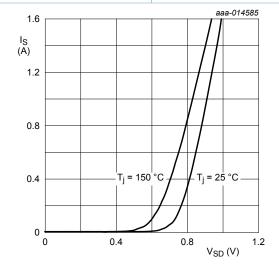
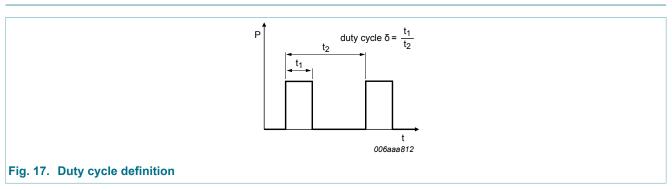


Fig. 16. Source current as a function of source-drain voltage; typical values

### 11. Test information

 $V_{GS} = 0 V$ 



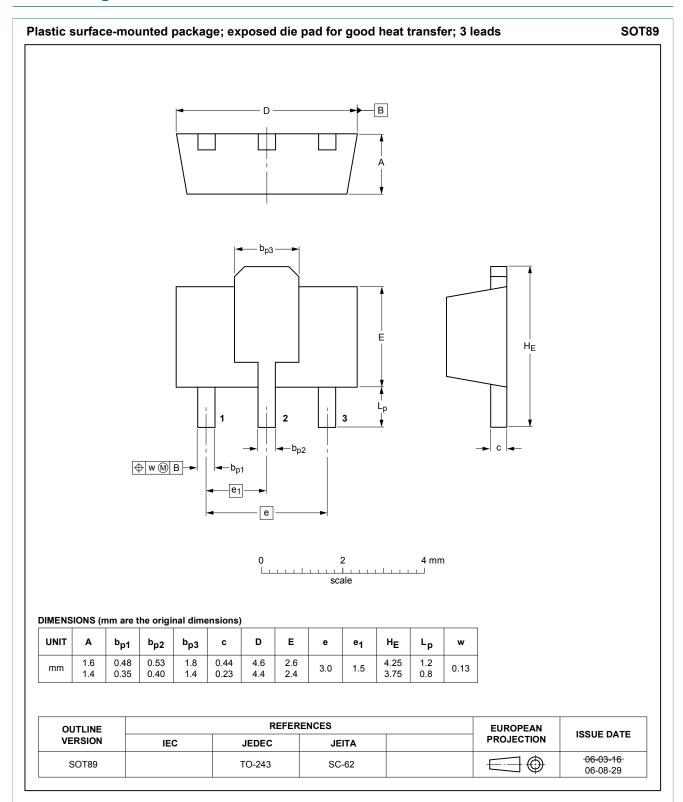
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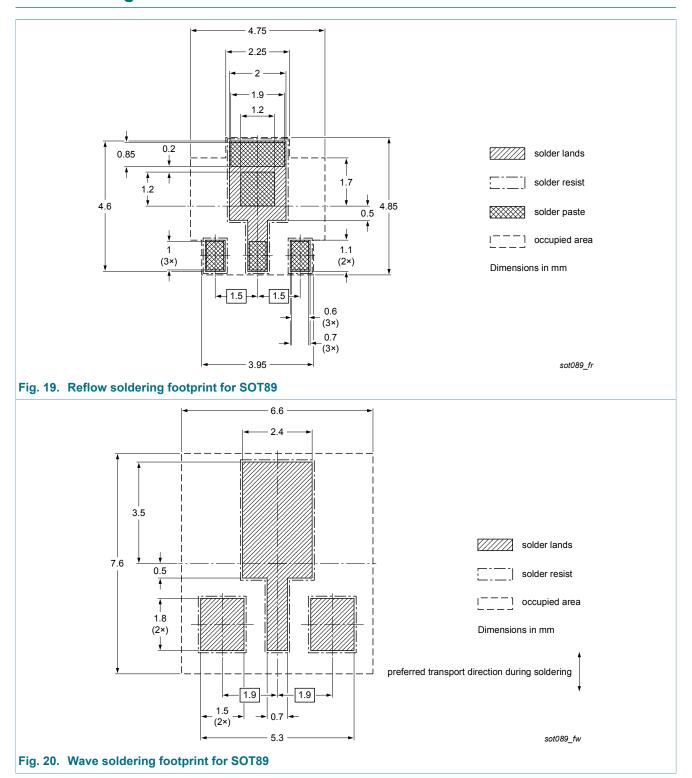
# 12. Package outline



**Product data sheet** 

### 200 V, N-channel vertical D-MOS transistor

## 13. Soldering



### 200 V, N-channel vertical D-MOS transistor

# 14. Revision history

### Table 8. Revision history

Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
BSS87 v.5	20141209	Product data sheet	-	BSS87 v.4
Modifications:	Figure 3 corrected.			,
BSS87 v.4	20140815	Product data sheet	-	BSS87 v.3
BSS87 v.3	20010518	Product specification	-	BSS87 v.2
BSS87 v.2	19970623	Product specification	-	BSS87 v.1

#### 200 V, N-channel vertical D-MOS transistor

### 15. Legal information

#### 15.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
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### 200 V, N-channel vertical D-MOS transistor

### 16. Contents

1	General description	1
2	Features and benefits	1
3	Applications	1
4	Quick reference data	1
5	Pinning information	2
6	Ordering information	2
7	Marking	2
8	Limiting values	3
9	Thermal characteristics	5
10	Characteristics	7
11	Test information	10
12	Package outline	11
13	Soldering	12
14	Revision history	13
15	Legal information	14
15.1	Data sheet status	14
15.2	Definitions	14
15.3	Disclaimers	14
15.4	Trademarks	15

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